Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/784,571	ONO, ATSUSHI
Examiner	Art Unit
Brian D. Nguyen	2616

	SEARCHED				
Class	Subclass	Date	Examiner		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
		DATE	EXMR
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